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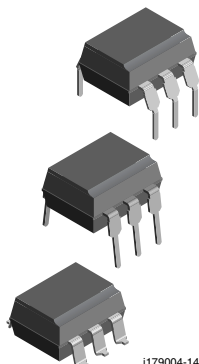
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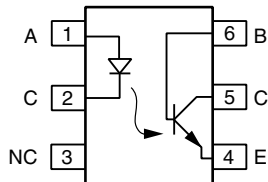




Optocoupler, Phototransistor Output, with Base Connection



i179004-14



FEATURES

- Isolation test voltage 5000 V_{RMS}
- Interfaces with common logic families
- Input-output coupling capacitance < 0.5 pF
- Industry standard dual-in-line 6-pin package
- Compliant to RoHS Directive 2002/95/EC and in accordance to WEEE 2002/96/EC

RoHS
COMPLIANT

APPLICATIONS

- AC mains detection
- Reed relay driving
- Switch mode power supply feedback
- Telephone ring detection
- Logic ground isolation
- Logic coupling with high frequency noise rejection

AGENCY APPROVALS

- UL file no. E52744
- cUL tested to CSA 22.2 bulletin 5A
- DIN EN 60747-5-2 (VDE 0884)/DIN EN 60747-5-5 (pending), available with option 1
- BSI: EN 60065, EN 60950-1
- FIMKO
- CQC

DESCRIPTION

The 4N25 family is an Industry Standard Single Channel Phototransistor Coupler. This family includes the 4N25, 4N26, 4N27, 4N28. Each optocoupler consists of gallium arsenide infrared LED and a silicon NPN phototransistor.

These couplers are Underwriters Laboratories (UL) listed to comply with a 5300 V_{RMS} isolation test voltage. This isolation performance is accomplished through special Vishay manufacturing process.

Compliance to DIN EN 60747-5-2 (VDE 0884)/DIN EN 60747-5-5 pending partial discharge isolation specification is available by ordering option 1.

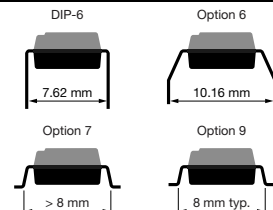
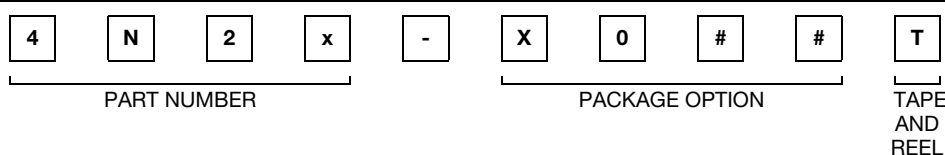
These isolation processes and the Vishay ISO9001 quality program results in the highest isolation performance available for a commercial plastic phototransistor optocoupler.

The devices are also available in lead formed configuration suitable for surface mounting and are available either on tape and reel, or in standard tube shipping containers.

Note

- For additional design information see application note 45 normalized curves

ORDERING INFORMATION



| AGENCY CERTIFIED/PACKAGE | CTR (%) | | | |
|--------------------------|---------------------------|---------------------------|---------------------------|---------------------------|
| UL, cUL, BSI, FIMKO | ≥ 20 | | ≥ 10 | |
| DIP-6 | 4N25-X000 | - | 4N27-X000 | - |
| DIP-6, 400 mil, option 6 | 4N25-X006 | 4N26-X006 | - | - |
| SMD-6, option 7 | 4N25-X007T | - | 4N27-X007 | - |
| SMD-6, option 9 | 4N25-X009T ⁽¹⁾ | 4N26-X009T ⁽¹⁾ | 4N27-X009T ⁽¹⁾ | 4N28-X009T ⁽¹⁾ |
| VDE, UL, cUL, BSI, FIMKO | ≥ 20 | | ≥ 10 | |
| DIP-6 | 4N25-X001 | 4N26-X001 | - | 4N28-X001 |
| DIP-6, 400 mil, option 6 | 4N25-X016 | 4N26-X016 | - | - |
| SMD-6, option 7 | 4N25-X017T ⁽¹⁾ | 4N26-X017T ⁽¹⁾ | 4N27-X017T | - |

Notes

- Additional options may be possible, please contact sales office.
- ⁽¹⁾ Also available in tubes; do not put T on end.



| ABSOLUTE MAXIMUM RATINGS ($T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified) | | | | |
|---|---|------------|----------------|--------------------|
| PARAMETER | TEST CONDITION | SYMBOL | VALUE | UNIT |
| INPUT | | | | |
| Reverse voltage | | V_R | 6 | V |
| Forward current | | I_F | 60 | mA |
| Surge current | $t \leq 10\text{ }\mu\text{s}$ | I_{FSM} | 2.5 | A |
| Power dissipation | | P_{diss} | 70 | mW |
| OUTPUT | | | | |
| Collector emitter breakdown voltage | | V_{CEO} | 70 | V |
| Emitter base breakdown voltage | | V_{EBO} | 7 | V |
| Collector current | | I_C | 50 | mA |
| Collector peak current | $t_p/T = 0.5$, $t_p \leq 10\text{ ms}$ | I_{CM} | 100 | mA |
| Output power dissipation | | P_{diss} | 150 | mW |
| COUPLER | | | | |
| Isolation test voltage | | V_{ISO} | 5000 | V_{RMS} |
| Creepage distance | | | ≥ 7 | mm |
| Clearance distance | | | ≥ 7 | mm |
| Isolation thickness between emitter and detector | | | ≥ 0.4 | mm |
| Comparative tracking index | DIN IEC 112/VDE0303, part 1 | | ≥ 175 | |
| Isolation resistance | $V_{IO} = 500\text{ V}$, $T_{amb} = 25\text{ }^{\circ}\text{C}$ | R_{IO} | $\geq 10^{12}$ | Ω |
| | $V_{IO} = 500\text{ V}$, $T_{amb} = 100\text{ }^{\circ}\text{C}$ | R_{IO} | $\geq 10^{11}$ | Ω |
| Storage temperature | | T_{stg} | - 55 to + 150 | $^{\circ}\text{C}$ |
| Operating temperature | | T_{amb} | - 55 to + 100 | $^{\circ}\text{C}$ |
| Junction temperature | | T_j | 100 | $^{\circ}\text{C}$ |
| Soldering temperature ⁽¹⁾ | 2 mm from case, $\leq 10\text{ s}$ | T_{sld} | 260 | $^{\circ}\text{C}$ |

Notes

- Stresses in excess of the absolute maximum ratings can cause permanent damage to the device. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operational sections of this document. Exposure to absolute maximum ratings for extended periods of the time can adversely affect reliability.
- Refer to reflow profile for soldering conditions for surface mounted devices (SMD). Refer to wave profile for soldering conditions for through hole devices (DIP).

| ELECTRICAL CHARACTERISTICS ($T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified) | | | | | | | |
|---|---|------|----------------------|------|------|------|---------------|
| PARAMETER | TEST CONDITION | PART | SYMBOL | MIN. | TYP. | MAX. | UNIT |
| INPUT | | | | | | | |
| Forward voltage ⁽¹⁾ | $I_F = 50\text{ mA}$ | | V_F | | 1.36 | 1.5 | V |
| Reverse current ⁽¹⁾ | $V_R = 3.0\text{ V}$ | | I_R | | 0.1 | 100 | μA |
| Capacitance | $V_R = 0\text{ V}$ | | C_O | | 25 | | pF |
| OUTPUT | | | | | | | |
| Collector base breakdown voltage ⁽¹⁾ | $I_C = 100\text{ }\mu\text{A}$ | | BV_{CBO} | 70 | | | V |
| Collector emitter breakdown voltage ⁽¹⁾ | $I_C = 1.0\text{ mA}$ | | BV_{CEO} | 30 | | | V |
| Emitter collector breakdown voltage ⁽¹⁾ | $I_E = 100\text{ }\mu\text{A}$ | | BV_{ECO} | 7 | | | V |
| $I_{CEO}(\text{dark})$ ⁽¹⁾ | $V_{CE} = 10\text{ V}$, (base open) | 4N25 | | | 5 | 50 | nA |
| | | 4N26 | | | 5 | 50 | nA |
| | | 4N27 | | | 5 | 50 | nA |
| | | 4N28 | | | 10 | 100 | nA |
| $I_{CBO}(\text{dark})$ ⁽¹⁾ | $V_{CB} = 10\text{ V}$, (emitter open) | | | | 2.0 | 20 | nA |
| Collector emitter capacitance | $V_{CE} = 0$ | | C_{CE} | | 6.0 | | pF |
| COUPLER | | | | | | | |
| Isolation test voltage ⁽¹⁾ | Peak, 60 Hz | | V_{IO} | 5000 | | | V |
| Saturation voltage, collector emitter | $I_{CE} = 2.0\text{ mA}$, $I_F = 50\text{ mA}$ | | $V_{CE(\text{sat})}$ | | | 0.5 | V |
| Resistance, input output ⁽¹⁾ | $V_{IO} = 500\text{ V}$ | | R_{IO} | 100 | | | $G\Omega$ |
| Capacitance, input output | $f = 1\text{ MHz}$ | | C_{IO} | | 0.5 | | pF |

Notes

- Minimum and maximum values are testing requirements. Typical values are characteristics of the device and are the result of engineering evaluation. Typical values are for information only and are not part of the testing requirements.
- JEDEC registered values are 2500 V, 1500 V, 1500 V and 500 V for the 4N25, 4N26, 4N27, and 4N28 respectively.

CURRENT TRANSFER RATIO ($T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified)

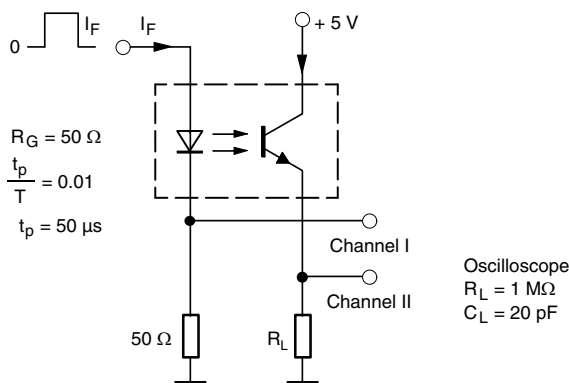
| PARAMETER | TEST CONDITION | PART | SYMBOL | MIN. | TYP. | MAX. | UNIT |
|-----------|---|------|------------|------|------|------|------|
| I_C/I_F | $V_{CE} = 10\text{ V}$, $I_F = 10\text{ mA}$ | 4N25 | CTR_{DC} | 20 | 50 | | % |
| | | 4N26 | CTR_{DC} | 20 | 50 | | % |
| | | 4N27 | CTR_{DC} | 10 | 30 | | % |
| | | 4N28 | CTR_{DC} | 10 | 30 | | % |

Note

- Indicates JEDEC registered values.

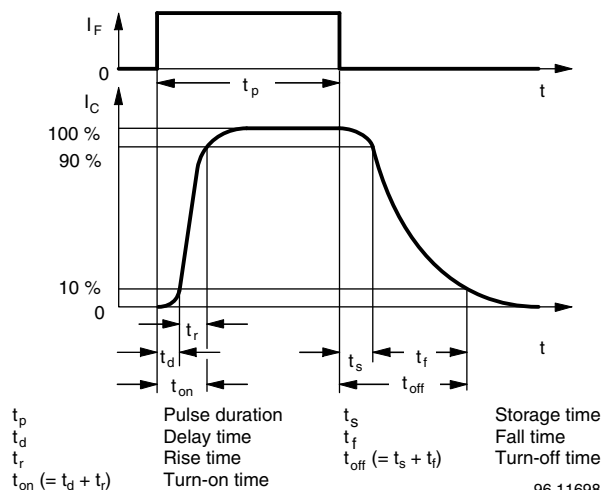
SWITCHING CHARACTERISTICS ($T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified)

| PARAMETER | TEST CONDITION | SYMBOL | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--------|------|------|------|---------------|
| Rise time | $V_{CC} = 5\text{ V}$, $I_F = 10\text{ mA}$, $R_L = 100\text{ }\Omega$ | t_r | | 2.0 | | μs |
| Fall time | $V_{CC} = 5\text{ V}$, $I_F = 10\text{ mA}$, $R_L = 100\text{ }\Omega$ | t_f | | 2.0 | | μs |



95 10804-3

Fig. 1 - Test Circuit, Non-Saturated Operation



96 11698

Fig. 2 - Switching Times

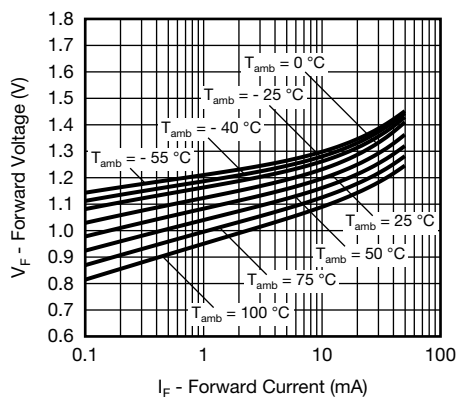
TYPICAL CHARACTERISTICS ($T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified)


Fig. 3 - Forward Voltage vs. Forward Current

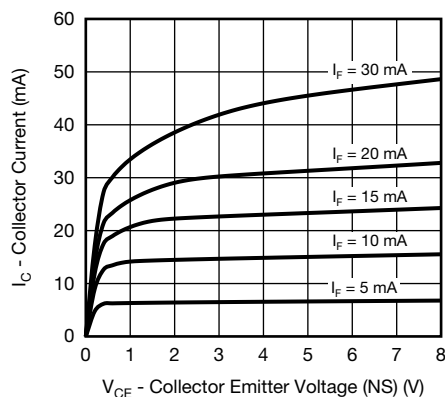


Fig. 4 - Collector Current vs. Collector Emitter Voltage (NS)

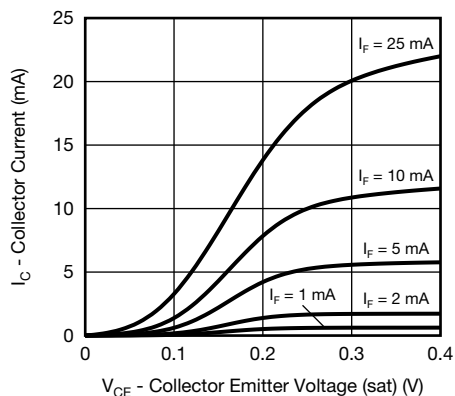


Fig. 5 - Collector Current vs. Collector Emitter Voltage (sat)

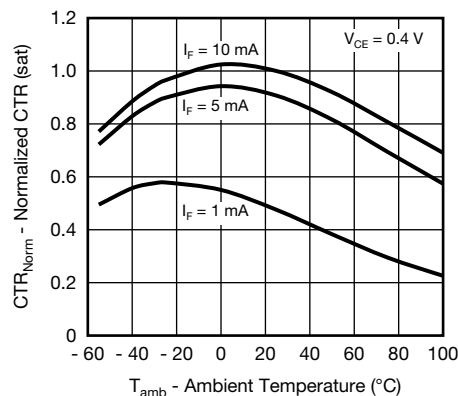


Fig. 8 - Normalized CTR (sat) vs. Ambient Temperature

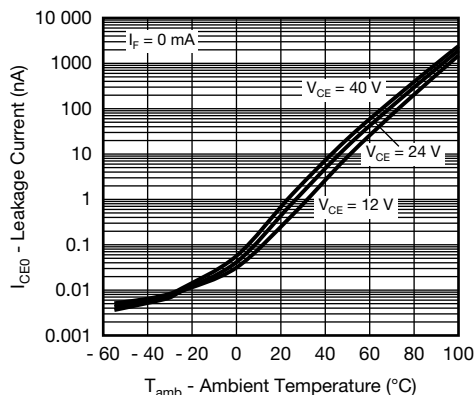


Fig. 6 - Leakage Current vs. Ambient Temperature

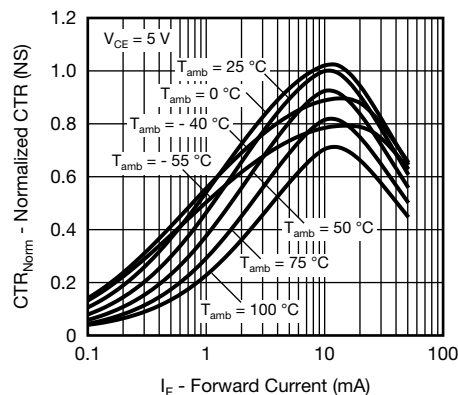


Fig. 9 - Normalized CTR (NS) vs. Forward Current

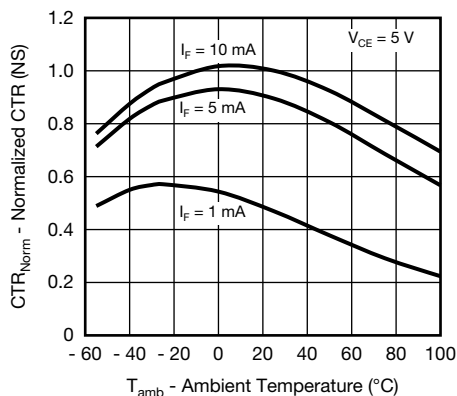


Fig. 7 - Normalized CTR (NS) vs. Ambient Temperature

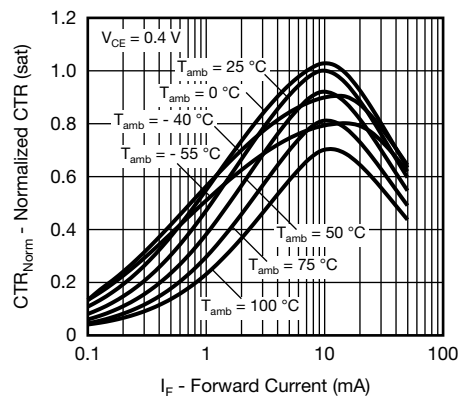


Fig. 10 - Normalized CTR (sat) vs. Forward Current

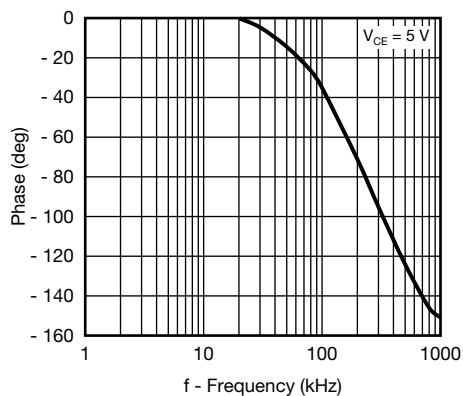


Fig. 11 - CTR Frequency vs. Phase Angle

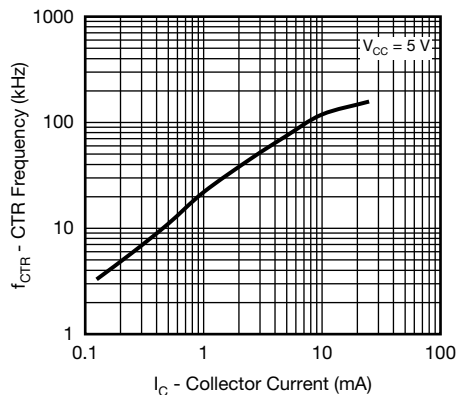


Fig. 12 - CTR Frequency vs. Collector Current

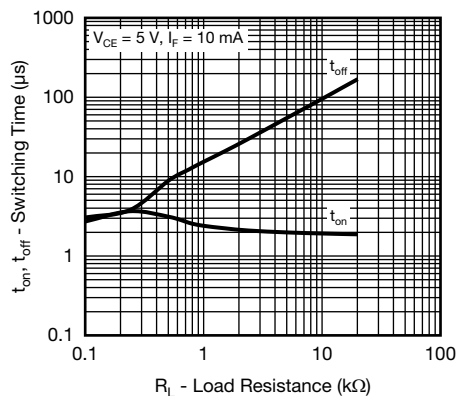
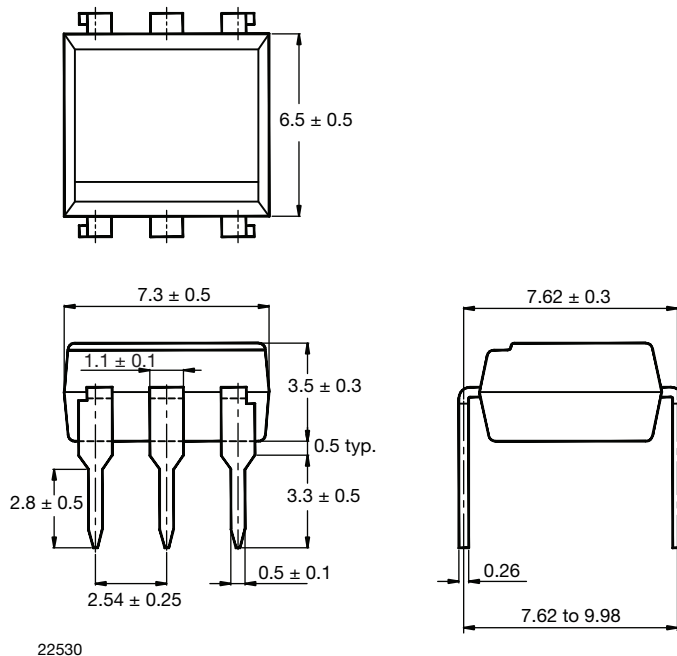


Fig. 13 - Switching Time vs. Load Resistance

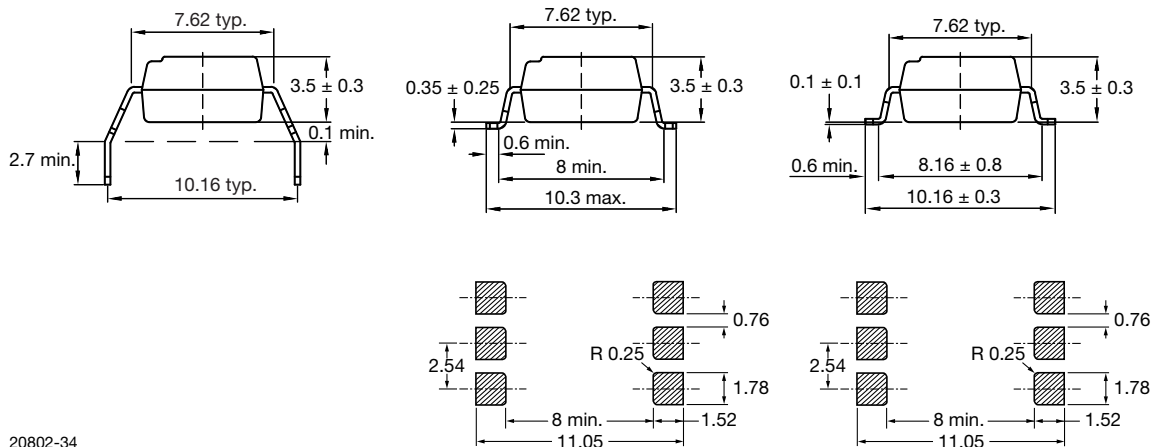
PACKAGE DIMENSIONS in millimeters



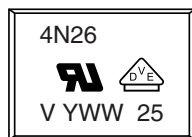
Option 6

Option 7

Option 9



PACKAGE MARKING



Notes

- VDE logo is only marked on option 1 parts. Option information is not marked on the part.
- Tape and reel suffix (T) is not part of the package marking.



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